

NEWS FROM MEDIPIX3 MEASUREMENTS AND IMPACT ON TIMEPIX2

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Outline

- Medipix3 introduction
- Chip description
- Electrical characterization summary
- Towards Medipix3 Si assemblies
- Conclusions
- Towards Timepix2



Medipix3 Introduction

 Medipix3 builds on the success of Medipix2 as a single photon counting imaging chip

- Added Features
 - Analogue charge summing to keep all charge information
 - Spectroscopic mode with 8 threshold levels
 - Continuous Count-Read mode (no dead time)
 - 2 programmable depth binary counters (variable dynamic range)
 - Flexible readout scheme (ROI, configurable output port width)
 - Highly configurable
- Designed in a 130nm 8-metal CMOS technology

Medipix3 introduction

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Medipix3 chip

Medipix3 introduction

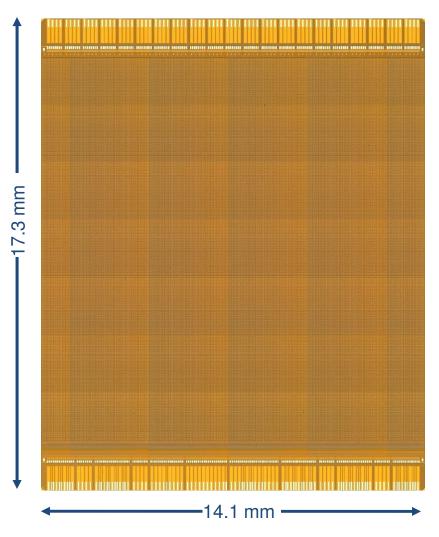
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- Pixel matrix of 256 x 256 pixels
- Bottom periphery contains:
 - LVDS drivers and receivers (500 Mbps)
 - Band-Gap and 25 DACs (10 9-bit and 15 8-bit)
 - 32 e-fuse bits
 - EoC and 2 Test pulse generators per pixel column
 - Temperature sensor
 - Full IO logic and command decoder
 - Power/Ground pads
 - TSV landing pads
 - Pads extenders
- Top periphery contains:
 - Power/Ground pads
 - TSV landing pads
 - Pads extenders
- > 115 Million transistors
- Typical power consumption:
 - 600 mW in Single pixel mode
 - 900 mW in Charge summing mode





Multiple dicing options

Medipix3 introduction

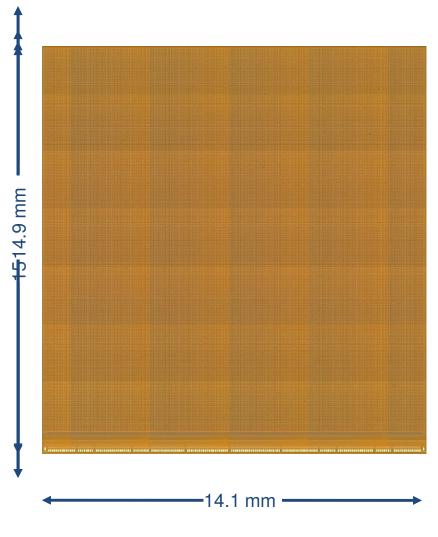
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	X [μm]	Υ [μm]	Active Area
Medipix2 and Timepix	14111	16120	87.1%
Medipix3 top and bottom WB	14100	17300	81.2%
Medipix3 bottom WB	14100	15900	88.4%
Medipix3 top and bottom TVS	14100	15300	91.9%
Medipix3 bottom TVS	14100	14900	94.3%





Medipix3 pixel Modes

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Pixel Operation Modes	Pixel size	# Thresholds	
Single Pixel	Fine Ditah Made > 55 um y 55 um	2	
Charge Summing	Fine Pitch Mode → 55 μm x 55 μm	۷	
Colour Mode	Construction Made 1140 was with 0 was	0	
Colour Mode with charge Summing	Spectroscopic Mode → 110 μm x 110 μm	8	
Pixel Gain Modes	Linearity	# Thresholds	
High Gain Mode	~10 ke ⁻	0	
Low Gain Mode	~20 ke ⁻	2	
Pixel Counter Modes	Dynamic range	# Counters	
Pixel Counter Modes 1-bit	Dynamic range	# Counters 2	
	Dynamic range 1 15		
1-bit	1	2	
1-bit 4-bit	1 15	2	
1-bit 4-bit 12-bit	1 15 4095	2 2 2	
1-bit 4-bit 12-bit 24-bit	1 15 4095 16777215	2 2 2 1	



Charge summing and allocation concept

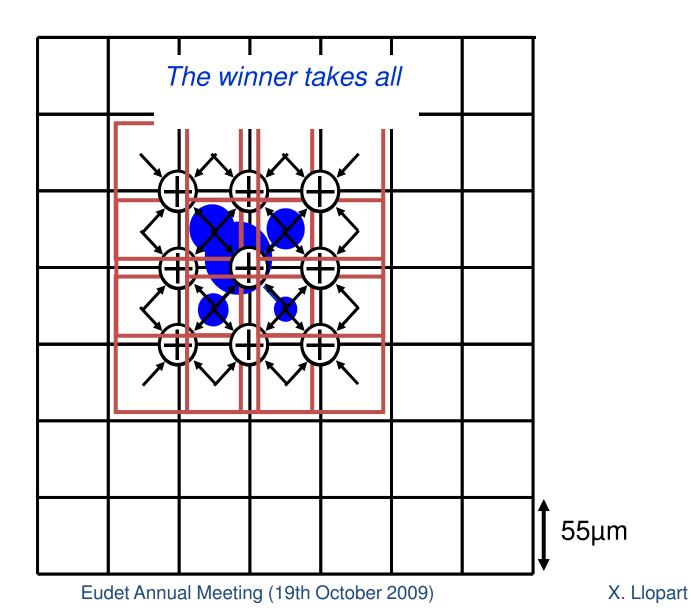
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Medipix3 Cell Schematic

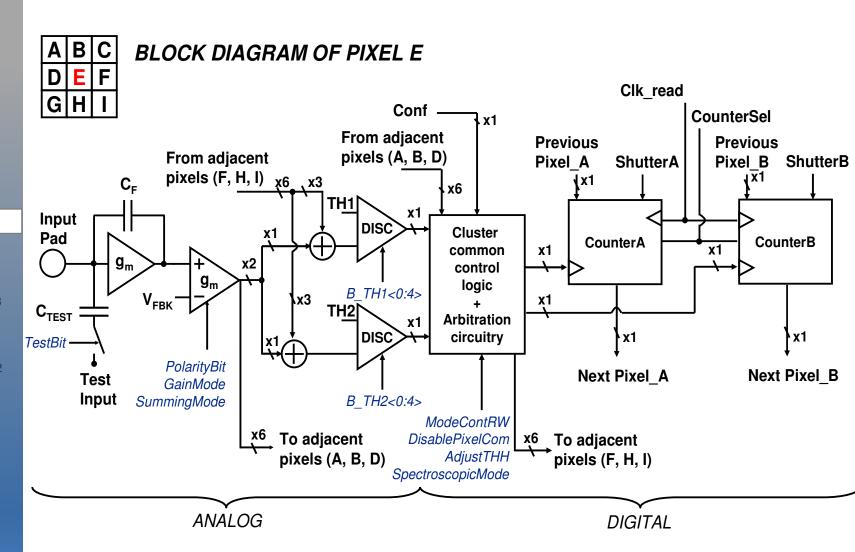
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Pixel Layout

- Design fully exploits the 130 nm CMOS technology
- ~1600 transistors per pixel

Medipix3 introduction

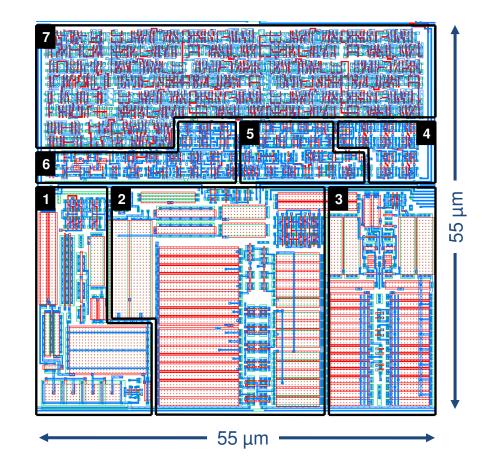
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- 1. Preamplifier
- 2. Shaper
- 3. Two discriminators with 5-bit threshold adjustment
- 4. Pixel memory (13-bits)
- 5. Arbitration logic for charge allocation
- 6. Control logic
- 7. Configurable counter





Electrical characterization

 Using the S-curve method the ENC, gain and threshold can be extracted

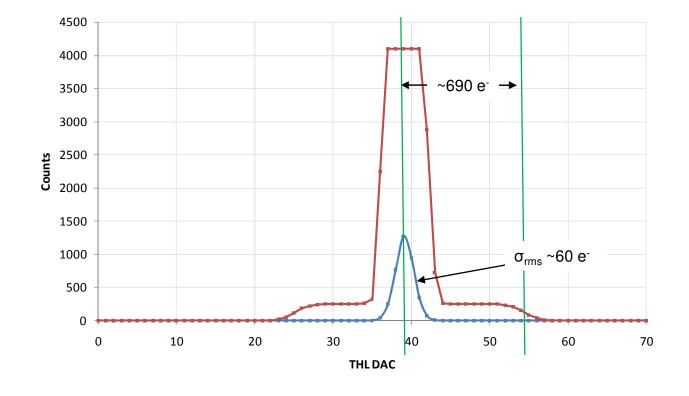
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Full chip ENC distribution

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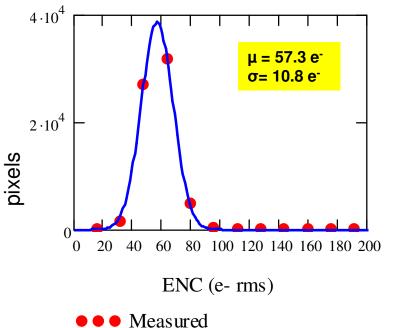
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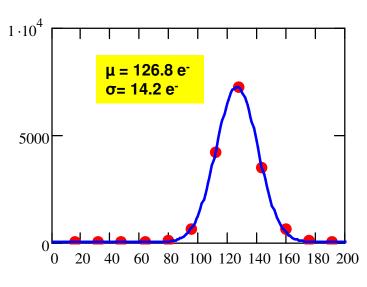
Towards Timepix2

Single Pixel Mode



MeasuredFitted gaussian

Charge Summing Mode (1/4th of the pixel matrix)

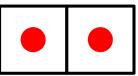


ENC (e- rms)

MeasuredFitted gaussian



Measurement in charge summing



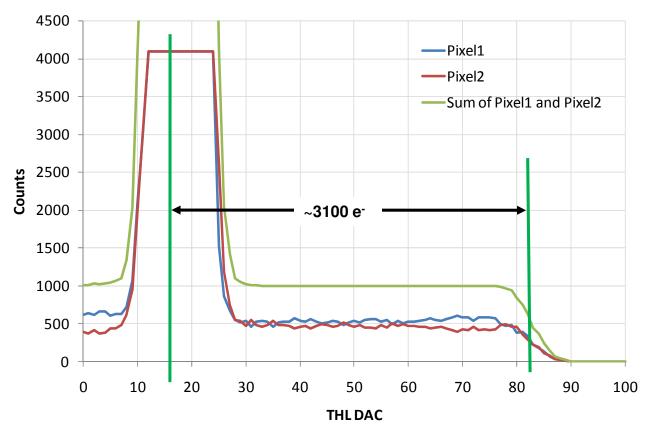
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Electrical pixel measurements summary

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Towards Timepix2

		Single Pixel Mode	Charge Summing Mode		
CSA Gain		11.4 mV/ke⁻			
CSA-Shapper Gain	High Gain	34 nA/ke ⁻			
	Low Gain	20 nA/ke ⁻			
Non Lingarity	High Gain	<5% up to 10 ke ⁻			
Non-Linearity	Low Gain	<5% up to 20 ke ⁻			
Peaking time	HG / LG	~110 ns			
Return to baseline	High Gain	<1.5 μs for 12 ke ⁻			
	Low Gain	<2.5 μs for 25 ke ⁻			
Electronic noise (unbanded)	High Gain	~60 e-rms	~130 e ⁻ _{rms}		
Electronic noise (unbonded)	Low Gain	~85 e ⁻ rms	~180 e ⁻ _{rms}		
Unadjusted Threshold spread	High Gain	~1000 e ⁻ rms	~1800 e ⁻ rms		
Unadjusted Threshold spread	Low Gain	~1900 e ⁻ rms	~3200 e ⁻ rms		
Fun a ata d Minimuum thus alaak	High Gain	~450 e ⁻	~900 e ⁻		
Expected Minimum threshold*	High Gain	~650 e ⁻	~1300 e ⁻		
Pixel power consumption	HG/LG	8 μW	15 μW		

These electrical measurements have to be validated once the first Medipix3 assemblies will be available



3 design flaws found

- 1) The incomplete modeling of the analog multiplexers leakage current at full chip scale:
 - 2 DACs show shorter dynamic range output as expected
 - Temperature variations an increase induced radiation modifies the front-end bias operation point
- 2) The pixel input protection diode was not designed radiation hard:
 - The increase in leakage current degrades the analog performance of the pixel
- A new bias operation point of the pixel front-end has been found which allows more margin for bias voltages shifts
- 3) Incomplete mixed-signal modeling of a full custom logic block in the pixel counters:
 - Prevents the Continuous Count-Read mode to perform as designed.

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Wafer Probing Summary

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Name	#	AA	Bs	Cs	Ds	E	F	# Chips	Where
VK7DG2H	0							100	CERN/diced
VT7DCWH	1	27	10	11	45	3	4	100	CERN
VT7DEVH	2	71	17	2	2	6	2	100	Bump bonding
VV7DFAH	3	33	18	6	32	7	4	100	CERN
VN7DE0H	4	57	18	2	15	8	0	100	Bump bonding
VU7DCVH	5	18	5	1	63	10	3	100	CERN
VW7DF9H	6	36	18	4	30	6	6	100	CERN
VQ7DCZH	7	61	18	2	8	6	5	100	Bump bonding
VS7DCXH	8	6	0	1	84	9	0	100	CERN
VU7DDCH	9	47	21	2	16	12	2	100	CERN
VL7DFJH	10	33	19	7	36	5	0	100	CERN
VW7DDAH	11	48	22	5	15	9	1	100	CERN
		437	166	43	346	81	27	1100	
		39.7%	15.1%	3.9%	31.5%	7.4%	2.5%	100.0%	



Best and worst wafer

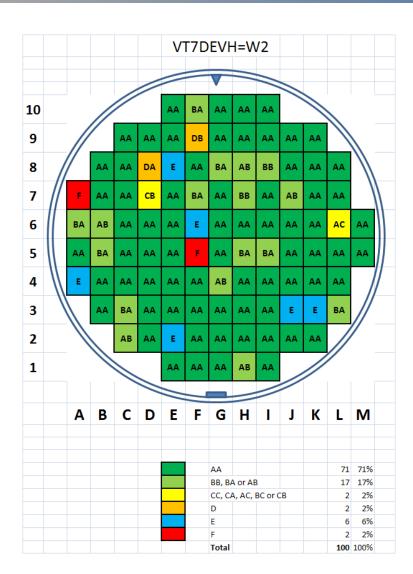
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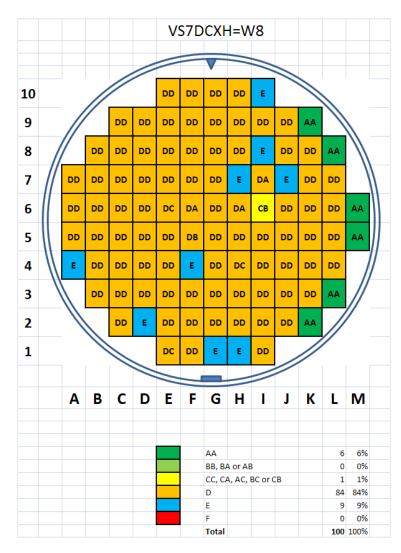
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First Medipix3 Assemblies @ CERN

- First 20 300 µm Si detectors bonded to single Medipix3 readout chips arrived at CERN this week end
- First assemblies will be mounted soon (today) and tested this week.
- First results to be presented next week in NSS-MIC09 (Orlando, USA)

Medipix3 introduction

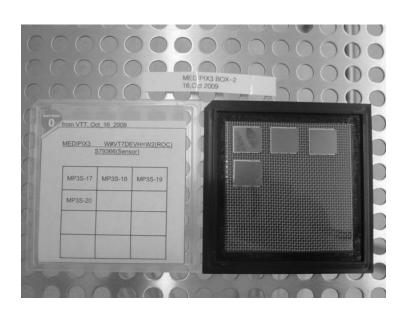
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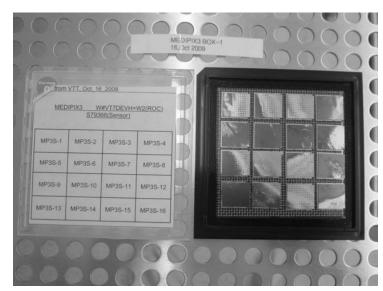
Electrical characterization summary

Towards Medipix3 Si assemblies

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Towards Timepix2





Images from Gädda Akiko (VTT, Finland)

Eudet Annual Meeting (19th October 2009)



Conclusions on Medipix3

- The Medipix3 chip is the first last scale mixed mode chip built in 130nm CMOS technology in the High Energy Physics community
- The chip is highly configurable and it is prepared for 4-side butting with an active area of ~95%
- The inter-pixel architecture aimed to minimize the impact of charge sharing on energy resolution works
- Electrical characterization is completed and measurements show good agreement with the designed values.
- Yield results are reasonable given the chip size
- First Si assemblies will be available this week and will be used to confirm electrical measurements

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Towards Timepix2 (I)

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- Many building blocks used in Medipix3 can be reused for a new chip:
 - Band-Gap and DACs
 - E-fuses
 - LVDS drivers and receivers
- Our design team at CERN is currently studying some ideas for new pixel front-ends (preamplifier and discriminators)
 - improved TOT linearity
 - Temperature robustness
 - Minimize pixel to pixel gain variations
- Also a new PLL is being studied
 - Low power ($<500 \mu W$)
 - Multiple output selection up to 100 MHz



Towards Timepix2 (II)

- In the Medipix3 collaboration there is a growing interest in Timepix2
- This development will be funded by the Medipix3 Consortium
- Main specs:
 - Pixel to measure TOT and Arrival time information simultaneously
 - <2ns time resolution</p>
 - Triggered readout
 - Sparse and very fast readout

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